## Notice of References Cited

Application/Control No. 10/692,360	Applicant(s)/ Reexaminati PARK, CHUI	
Examiner	Art Unit	
Viet Q Nauven	2818	Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,424,582	07-2002	Ooishi et al.	365/200
*	В	US-5,689,465	11-1997	Sukegawa et al.	365/200
*	С	US-6,536,002	03-2003	Kim, Nam-jong	714/710
*	D	US-6,414,901	07-2002	Shin, Youn Cherl	365/230.08
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Ъ			_		
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.